Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/790,868	TAKAMURA, TAKASHI
Examiner	Art Unit
Wai-Sing Louie	2814

	SEARCHED				
Class	Subclass	Date	Examiner		
257	184,187,2 18,222,22 6,231,257	7/18/2005	WSL		

INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
photodiode, solid state image sensor, charg accumulation, read/reset transistor, annular gate	7/18/2005	WSL		
		0		
<u>. </u>				